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Date of Deposit

**Jonathan M. Blanchard, Ph.D.**

Name \_\_\_\_\_

**Signature**

In re Application of:

Chad Mirkin, et al.

Serial No. 10/671,381

Filing Date: September 25, 2003

For SCANNING PROBE MICROSCOPY PROBE  
AND METHOD FOR SCANNING PROBE  
CONTACT PRINTING

### Examiner To Be Assigned

Group Art Unit No. 2881

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. § 1.56, Applicants request that citation and examination of the references identified on the attached PTO-1449 form, be made during the course of examination of the above-referenced application for United States Letters Patent.


This application is a divisional application of Serial No. 10/440,022. Accordingly, all information previously submitted to and/or cited by the Examiner is not provided, according to 37 C.F.R. § 1.98(d).

The Commissioner is hereby authorized to charge any fees associated with this communication not covered by check or credit card payment or credit any overpayment to Deposit Account No. 50-3123. A duplicate copy of this sheet is attached.

Respectfully submitted,

Jonathan M. Blanchard, Ph.D.  
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Form PTO-1449 (Rev. 8-88)		Attorney Docket No. NWN01-002-DIV-US	Serial No. 10/671,381
<b>INFORMATION DISCLOSURE CITATION</b> (Use several sheets if necessary)		Applicant: Chad Mirkin, et al..	
		Filing Date: September 25, 2003	Group: 2881

### U.S. PATENT DOCUMENTS

Examiner Initials*		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	B1	5,883,387	03/1999				
	B2	6,156,215	12/2000				

### FOREIGN PATENT DOCUMENTS

Examiner Initials*		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	B3	EP 0786642	07/1997	EP				
	B4	WO99/56176	11/1999	WO				

### OTHER ITEMS - NON PATENT LITERATURE DOCUMENTS

Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages

Examiner Initials*								
	B5	Higa, K. et al., "Fabrication of Microcantilever with a Silicon Tip Prepared by Anodization", Japanese Journal of Applied Physics, vol. 37, no. 12B, pp. 7078-7080, (1998).						
	B6	International Search Report for Application No. PCT/US2004/015161 dated October 27, 2004.						

Examiner	Date Considered
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.